P-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^c	Q _g (Typ.)		
- 20	0.34 at V _{GS} = - 4.5 V	- 0.75	1.3 nC		
- 20	0.49 at V _{GS} = - 2.5 V	- 0.53	1.5110		

FEATURES

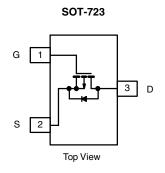
- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFET
- 100 % R_g Tested
 Compliant to RoHS Directive 2002/95/EC

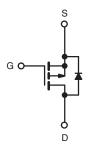


HALOGEN FREE

APPLICATIONS

- Load Switch
- DC/DC Converters





P-Channel MOSFET

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	- 20	.,	
Gate-Source Voltage		V _{GS}	± 12	V
	T _C = 25 °C		- 0.75	
Continuous Drain Current (T _J = 150 °C)	T _C = 70 °C	1 . –	- 0.5	
Continuous Diairi Curient (1) = 130 C)	T _A = 25 °C	I _D	- 0.7 ^{a, b}	
	T _A = 70 °C		- 0.5 ^{a, b}	Α
Pulsed Drain Current	I _{DM}	- 3		
Continuous Course Dunin Diada Current	T _C = 25 °C	la la	- 0.4	
Continuous Source-Drain Diode Current	tinuous Source-Drain Diode Current $T_A = 25 ^{\circ}\text{C}$		- 0.3	
	T _C = 25 °C		0.25	
Manianum Barras Biasination	T _C = 70 °C	P _D	0.2	w
Maximum Power Dissipation	T _A = 25 °C	I D	0.2 ^{a, b}	
	T _A = 70 °C		0.2 ^{a, b}	
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 50 to 150	- °C	
Soldering Recommendations (Peak Temperature)		260		

Notes:

a. Surface mounted on 1" x 1" FR4 board.

b. t = 10 s.

c. Based on $T_C = 25$ °C.



THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^{a, b}	t ≤ 10 s	R _{thJA}	250	500	°C/W
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	225	670	C/VV

Notes:

a. Surface mounted on 1" x 1" FR4 board.

b. Maximum under steady state conditions is 360 °C/W.

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	- 20			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$			- 14		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μA		2.4		mv/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = - 250 μA	- 0.45		- 0.8	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			± 100	nA	
Zana Cata Valtana Busin Commant		V _{DS} = - 20 V, V _{GS} = 0 V			- 1		
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 20 V, V _{GS} = 0 V, T _J = 55 °C			- 10	μΑ	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	- 2			Α	
	` ,	V _{GS} = - 4.5 V, I _D = - 0.4 A	0.34				
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 2.5 V, I _D = - 0.2 A		0.49		Ω	
		V _{GS} = - 1.8 V, I _D = - 0.3 A		0.52			
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 5 V, I _D = - 0.4 A		5		S	
Dynamic ^b					•		
Input Capacitance	C _{iss}			72		pF	
Output Capacitance	C _{oss}	V _{DS} = - 10 V, V _{GS} = 0 V, f = 1 MHz		15			
Reverse Transfer Capacitance	C _{rss}			14			
·		$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -0.4 \text{ A}$		1.3	2.5	nC	
Total Gate Charge		20 00		1.7	2.1		
Gate-Source Charge	Q_{gs}	$V_{DS} = -10 \text{ V}, V_{GS} = -2.5 \text{ V}, I_{D} = -0.4 \text{ A}$		0.7			
Gate-Drain Charge	Q _{gd}			1.0			
Gate Resistance	R _a	f = 1 MHz	1.4	7	14	Ω	
Turn-On Delay Time	t _{d(on)}			12	20		
Rise Time	t _r	$V_{DD} = -10 \text{ V, R}_{1} = 9.1 \Omega$		20	30		
Turn-Off DelayTime	t _{d(off)}	$I_D \cong -0.4 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_q = 1 \Omega$		23	35		
Fall Time	t _f			9	18		
Turn-On Delay Time	t _{d(on)}			5	10	ns	
Rise Time	t _r	$V_{DD} = -10 \text{ V, R}_{1} = 9.1 \Omega$		10	20		
Turn-Off DelayTime				18	27		
Fall Time	t _f	,		7	14		
Drain-Source Body Diode Characterist	•			I			
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 0.7		
Pulse Diode Forward Current ^a	I _{SM}	Ü			- 6	Α	
Body Diode Voltage	V _{SD}	I _F = - 0.7 A		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}	·		18	27	ns	
Body Diode Reverse Recovery Charge	0			7	14	nC	
Reverse Recovery Fall Time	t _a	$I_F = -0.7 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		7		1	
Reverse Recovery Rise Time	t _b			11		ns	

Notes:

a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %.

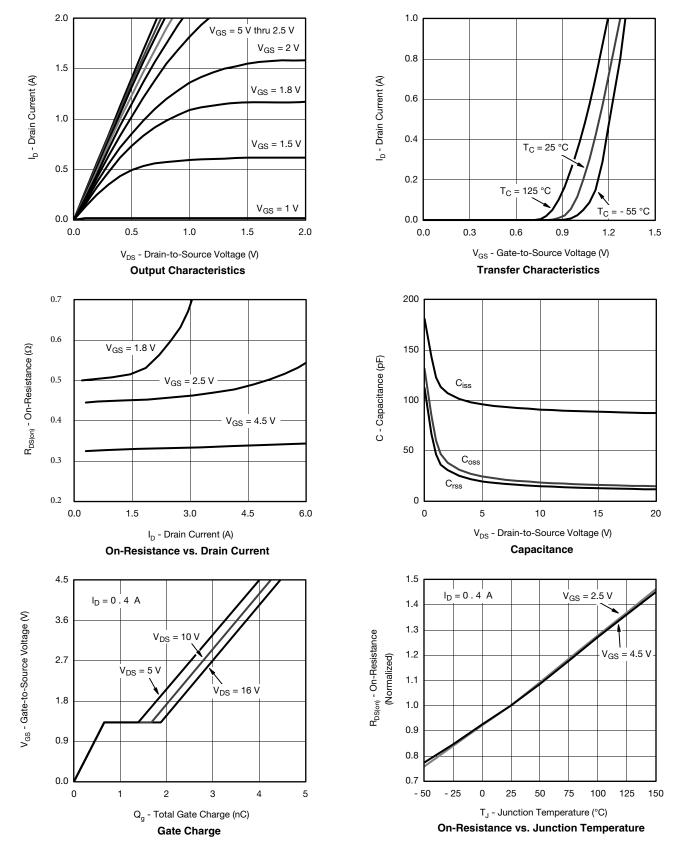
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

b. Guaranteed by design, not subject to production testing.



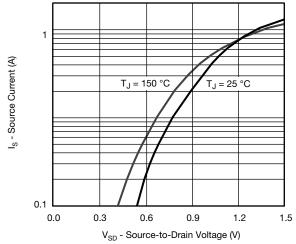


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

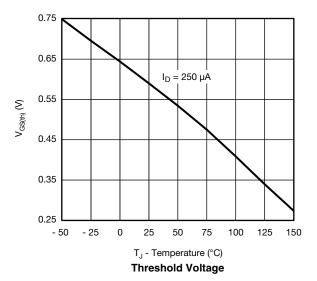


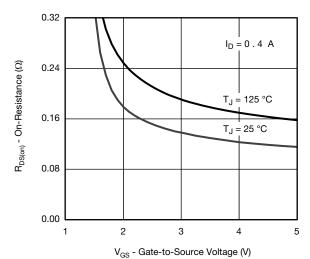


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

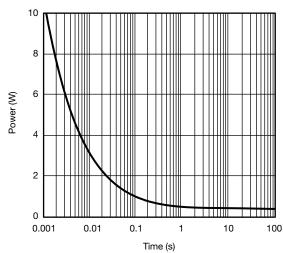


Source-Drain Diode Forward Voltage

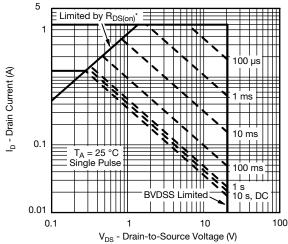




On-Resistance vs. Gate-to-Source Voltage



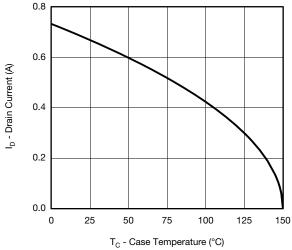
Single Pulse Power, Junction-to-Ambient



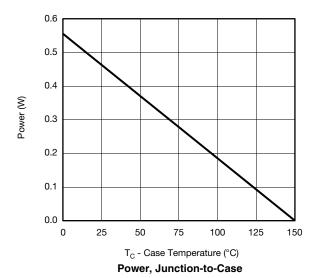
* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

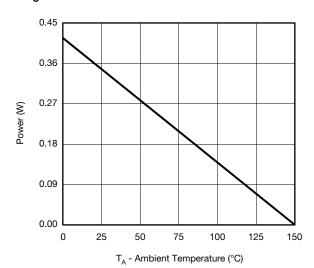
Safe Operating Area, Junction-to-Ambient

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)







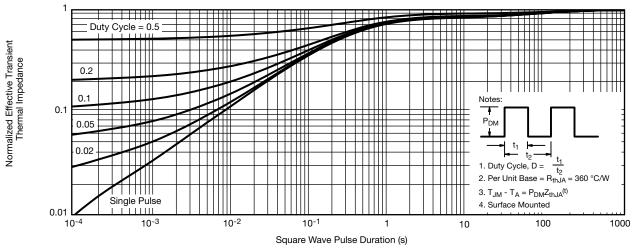


Power, Junction-to-Ambient

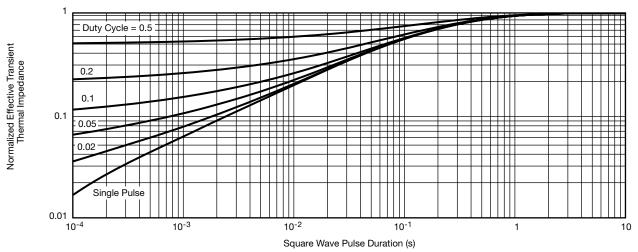
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



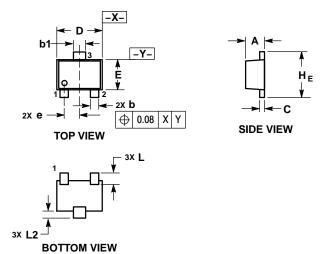
Normalized Thermal Transient Impedance, Junction-to-Foot



SOT-723



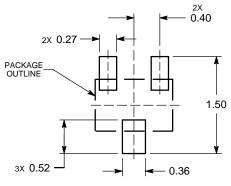
SCALE 4:1



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 2. CONTROLLING DIMENSION: MILLIMETERS.
 3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.
 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS.

	MILLIMETERS			
DIM	MIN	NOM	MAX	
Α	0.45	0.50	0.55	
b	0.15	0.21	0.27	
b1	0.25	0.31	0.37	
O	0.07	0.12	0.17	
D	1.15	1.20	1.25	
Е	0.75	0.80	0.85	
е	0.40 BSC			
ΗE	1.15	1.20	1.25	
Г	0.29 REF			
L2	0.15	0.20	0.25	

RECOMMENDED SOLDERING FOOTPRINT*



DIMENSIONS: MILLIMETERS





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